

Search Notes

Application/Control No.

10/664,936

Examiner

Cheukfan Lee

Applicant(s)/Patent under
Reexamination

HUANG ET AL.

Art Unit

2625

SEARCHED

Class	Subclass	Date	Examiner
358	475,509, 474,497	9/15/2006	C.L.
	483,482		
	471,494		
	473,472		
	512-514		
	505,506		
	487,484		
382	312,313		
	318,319		
250	208.1,216		
	239		
	234-236		
359	212		
355	67,68		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
358	474	9/15/2006	C.L.
	475		
	497		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search: search terms include: light\$3 with ((plural\$5 series row multiple) adj3 (slit pinhole (pin adj hole) aperture	9/15/2006	C.L.
(search terms cont.): hole))		
Inventor search		
Reference only: Fujimoto et al. (6,376,822), Fig. 7, a plurality of through-hole 43a (3 of them) for R, G and B		
My related case 10/256,425		